

Product data sheet

1. General description

Ultrafast power diode in a SOT186A (TO-220F) plastic package.

2. Features and benefits

- Ultra low leakage current
- High junction temperature up to 175 °C
- Low on-state loss
- Fast switching
- · Soft recovery characteristic minimizes power consuming oscillations
- High reverse surge capability
- High thermal cycling performance
- Low thermal resistance

3. Applications

- Home appliance power supply
- Secondary rectification

able 1. Q	uick reference data						
Symbol	Parameter	Conditions		Va	lues		Unit
Absolute	maximum rating						
V_{RRM}	repetitive peak reverse voltage		300				V
$I_{F(AV)}$	average forward current	δ = 0.5 ; square-wave pulse; T _h ≤ 126 °C; per diode; <u>Fig. 1; Fig. 2; Fig. 3</u>	10			A	
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t _p = 25 µs; T _h ≤ 126 °C; square-wave pulse; per diode	20			A	
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4		2	20		A
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	242			A	
Symbol	Parameter	Conditions	Min Typ Max		Max	Unit	
Static ch	aracteristics						
V _F	forward voltage	I _F = 10 A; T _j = 25 °C; per diode; <u>Fig. 6</u>		-	-	1.25	V
		I_{F} = 10 A; T_{j} = 125 °C; per diode; Fig. 6		-	-	1	A A Unit
Dynamic	characteristics		1		1	1	1
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$		-	-	25	ns

4. Quick reference data

BYV32EX-300P

Dual ultrafast power diode

5. Pinning information

Pinning infor	mation		
Symbol	Description	Simplified outline	Graphic symbol
A1	anode	mb	
К	cathode		
A2	anode		K sym125
mb	mounting base; isolated		
	SymbolA1KA2	A1anodeKcathodeA2anode	SymbolDescriptionSimplified outlineA1anodembKcathodeImplified outlineA2anode

6. Ordering information

Table 3. Ordering information									
Type number	Package	Orderable part number	Packing method	Small packing quantity		Package issue date			
	name		method	quantity	version	issue date			
BYV32EX-300P	TO-220F	BYV32EX-300PQ	Tube	50	SOT186A	14-Nov-2013			

7. Marking

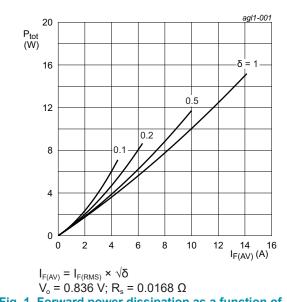
Table 4. Marking codes							
	Type number	Marking codes					
	BYV32EX-300P	BYV32EX-300P					

8. Limiting values

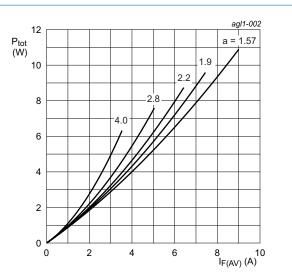
Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{RRM}	repetitive peak reverse voltage		300	V
V_{RWM}	crest working reverse voltage		300	V
V _R	reverse voltage	DC	300	V
$I_{F(AV)}$	average forward current	δ = 0.5 ; square-wave pulse; T _h ≤ 126 °C; per diode; <u>Fig. 1</u> ; <u>Fig. 2</u> ; <u>Fig. 3</u>	10	A
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t _p = 25 µs; T _h ≤ 126 °C; square-wave pulse; per diode	20	A
I _{O(AV)}	average output current	δ = 0.5 ; T _h ≤ 93 °C; square-wave pulse; both diodes conducting	20	A
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4	220	A
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	242	A
T _{stg}	storage temperature		-65 to 175	°C
Tj	junction temperature		175	°C

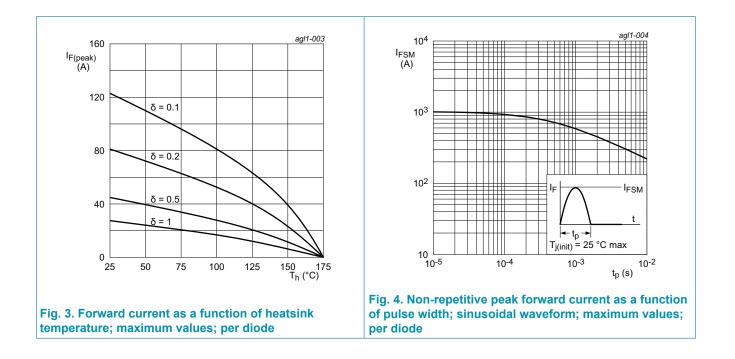


 $V_0 = 0.836$ V; $R_s = 0.0168 \Omega$ Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values; per diode



a = form factor = I_{F(RMS)} / I_{F(AV)} V_o = 0.836 V; R_s = 0.0168 Ω Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values; per diode

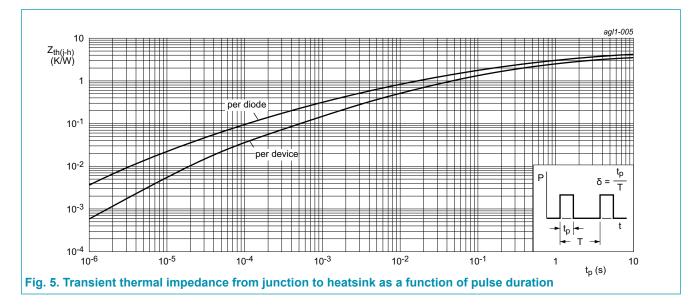
BYV32EX-300P Dual ultrafast power diode



Dual ultrafast power diode

9. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-h)}	thermal resistance from junction to	with heatsink compound; per diode; Fig. 5	-	-	4.2	K/W
	heatsink	with heatsink compound; both diodes conducting; Fig. 5	-	-	3.5	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient free air	in free air	-	60	-	K/W



10. Isolation characteristics

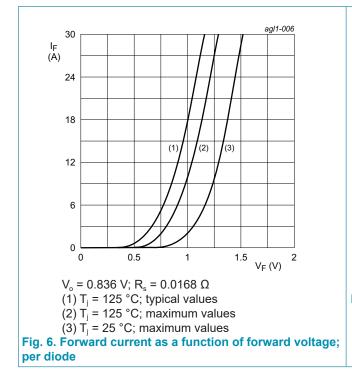
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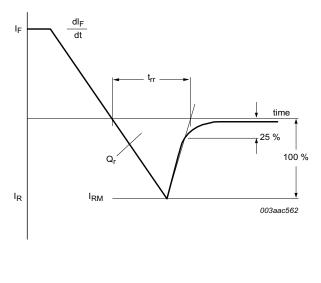
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{\text{isol}(\text{RMS})}$	RMS isolation voltage	50 Hz \leq f \leq 60 Hz; RH \leq 65 %; from all pins to external heatsink; sinusoidal waveform; clean and dust free	-	-	2500	V
C _{isol}	isolation capacitance	from cathode to external heatsink	-	10	-	PF

Dual ultrafast power diode

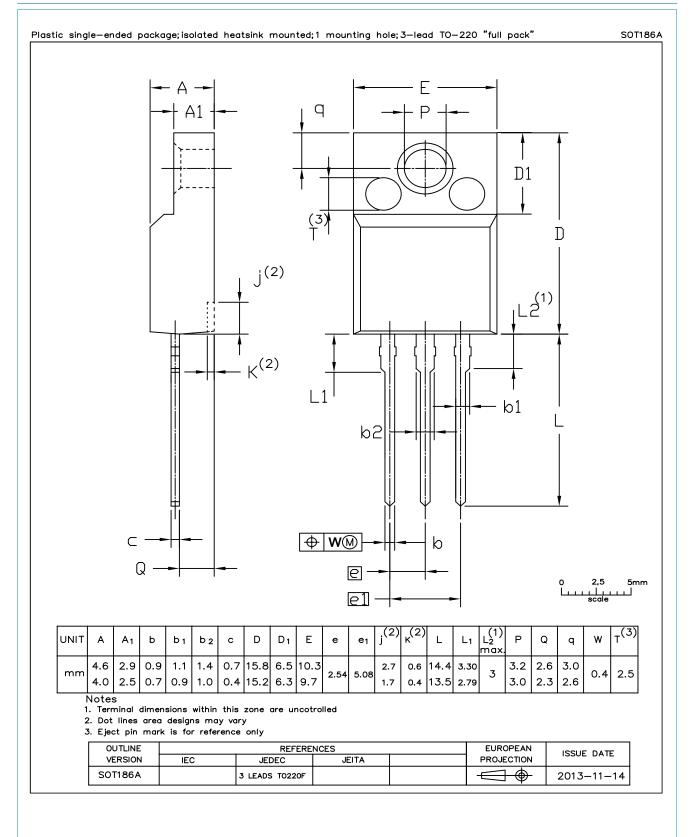
11. Characteristics

Table 8. Cl	naracteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _F	forward current	$I_{F} = 10 \text{ A}; T_{j} = 25 \text{ °C}; \text{ per diode}; Fig. 6$	-	-	1.25	V
		I _F = 10 A; T _j = 125 °C; per diode; <u>Fig. 6</u>	-	-	1	V
I _R	reverse current	$V_R = 300 \text{ V}; \text{ T}_j = 25 \text{ °C}; \text{ per diode}$	-	-	20	μA
		V_{R} = 300 V; T _j = 125 °C; per diode	-	-	300	μA
Dynamic	characteristics	1				
Q _r	reverse charge	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{ d}_F/\text{dt} = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	9	-	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 50 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; \frac{\text{Fig. 7}}{2}$	-	-	35	ns
		$I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{ d}_F/\text{dt} = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	-	25	ns
		$I_F = 10 \text{ A}; V_R = 200 \text{ V}; \text{ d}_F/\text{dt} = 200 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	25	-	ns
		I _F = 10 A; V _R = 200 V; dI _F /dt = 200 A/μs; T _j = 125 °C; per diode; <u>Fig. 7</u>	-	33	-	ns
I _{RM}	peak reverse recovery current	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{ d}_F/\text{dt} = 50 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	0.7	-	A
		$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	1.1	-	A
		$I_F = 10 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	2.8	-	A
		$I_F = 10 \text{ A}; V_R = 200 \text{ V}; dI_F/dt = 200 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; \text{ per diode; } \frac{\text{Fig. 7}}{2}$	-	-	8	A





12. Package outline



BYV32EX-300P

Dual ultrafast power diode

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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